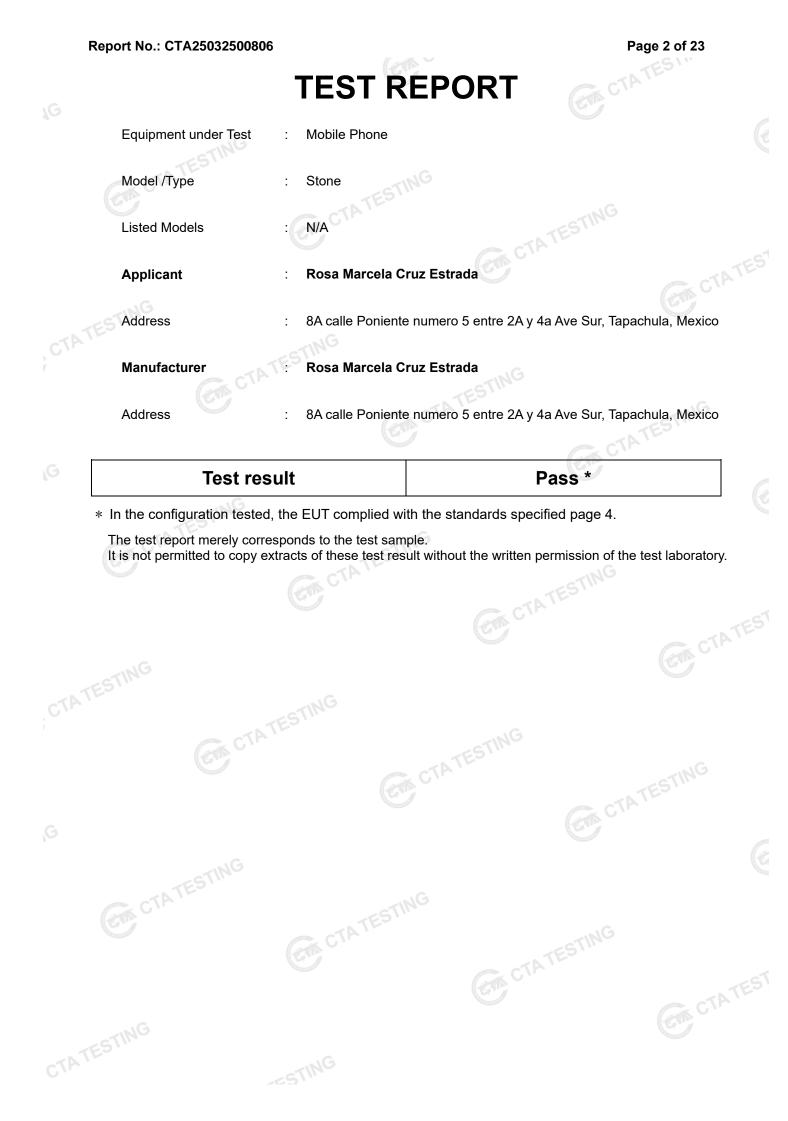


Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

	G FCC Part 27	
	: CTA25032500806 : 2AW5V-STONE	
Compiled by (position+printed name+	+signature) .: File administrators Joan Wu	
Supervised by (position+printed name+	+signature) .: Project Engineer Zoey Cao	Ltd
Approved by (position+printed name+	+signature) .: RF Manager Eric Wang	
Date of issue	Apr. 03, 2025	
Testing Laboratory Nan	me Shenzhen CTA Testing Technology Co., Ltd.	0
Address	Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Comm Fuhai Street, Baoʻan District, Shenzhen, China	unity
Applicant's name	Rosa Marcela Cruz Estrada	
Address	8A calle Poniente numero 5 entre 2A y 4a Ave Sur, Tapachula, N	lexic
Test specification	FCC CFR Title 47 Part 2, Part 27	
Standard	ANSI/TIA-603-E-2016	
	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved.	
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material, Shenzhen CTA	ANSI/TIA-603-E-2016 KDB 971168 D01	
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the a Testing Technology Co., Ltd. takes no responsibility for and will not assume lia om the reader's interpretation of the reproduced material due to its placement Mobile Phone	
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the Testing Technology Co., Ltd. takes no responsibility for and will not assume lia om the reader's interpretation of the reproduced material due to its placement Mobile Phone MARKPHONE	and
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description Trade Mark	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the Testing Technology Co., Ltd. takes no responsibility for and will not assume lia om the reader's interpretation of the reproduced material due to its placement Mobile Phone MARKPHONE	and
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description Trade Mark Manufacturer	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the Testing Technology Co., Ltd. takes no responsibility for and will not assume lia om the reader's interpretation of the reproduced material due to its placement Mobile Phone MARKPHONE	and
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description Trade Mark Manufacturer Model/Type reference	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the Testing Technology Co., Ltd. takes no responsibility for and will not assume lia tom the reader's interpretation of the reproduced material due to its placement Mobile Phone MARKPHONE	and
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the a Testing Technology Co., Ltd. takes no responsibility for and will not assume lia form the reader's interpretation of the reproduced material due to its placement Mobile Phone MARKPHONE Rosa Marcela Cruz Estrada Stone N/A	and
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description Trade Mark Manufacturer Model/Type reference Listed Models	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the a Testing Technology Co., Ltd. takes no responsibility for and will not assume lia form the reader's interpretation of the reproduced material due to its placement Mobile Phone MARKPHONE Rosa Marcela Cruz Estrada Stone N/A	and
Shenzhen CTA Testing This publication may be r Shenzhen CTA Testing Te material. Shenzhen CTA for damages resulting fro context. Test item description Trade Mark Manufacturer Model/Type reference Listed Models Ratings	ANSI/TIA-603-E-2016 KDB 971168 D01 Technology Co., Ltd. All rights reserved. reproduced in whole or in part for non-commercial purposes as long as the fechnology Co., Ltd. is acknowledged as copyright owner and source of the Testing Technology Co., Ltd. takes no responsibility for and will not assume liatom the reader's interpretation of the reproduced material due to its placement Image: Mobile Phone Image: MARKPHONE Image: Rosa Marcela Cruz Estrada Image: Stone Image: N/A Image: DC 3.7V From battery and DC 5.0V From external circuit Image: QPSK, 16QAM	and



Contents

К		Page 5 01 25
	Contents	
	SUMMARY	GV
1		
	1.1 TEST STANDARDS	
	1.2 Test Description	
	1.3 Address of the test laboratory	
	1.4 Test Facility	
	1.5 Statement of the measurement uncertainty	5
2	GENERAL INFORMATION	
	2.1 Environmental conditions	
	2.2 General Description of EUT	6
	2.3 Description of Test Modes and Test Frequency	
	2.4 Equipments Used during the Test	
	2.5 Related Submittal(s) / Grant (s)	
	2.6 Modifications.	
3	TEST CONDITIONS AND RESULTS	9
1AY	3.1 Output Power	
W -	3.2 Peak-to-Average Ratio (PAR)	
	3.3 Occupied Bandwidth and Emission Bandwidth	
	3.4 Band Edge compliance	
	3.5 Spurious Emission	
	3.6 Frequency Stability under Temperature & Voltage Variations	
4	Test Setup Photos of the EUT	
5	Photos of the EUT	
-	-	

SUMMARY 1

1.1 TEST STANDARDS

The tests were performed according to following standards:

FCC Part 2: FREQUENCY ALLOCA-TIONS AND RADIO TREATY MAT-TERS; GENERAL RULES AND REG-ULATIONS

FCC Part 27 : MISCELLANEOUS WIRELESS COMMUNICATIONS SERVICES

ANSI/TIA-603-E-2016: Land Mobile FM or PM Communications Equipment Measurement and Performance Standards.

ANSI C63.26-2015: IEEE/ANSI Standard for Compliance Testing of Transmitters Used in Licensed CTATES Radio Services

FCCKDB971168D01 Power Meas License Digital Systems

1.2 Test Description

Test Item	Section in CFR 47	Result
RF Output Power	Part 2.1046 Part 27.50(c)(10)	Pass
Peak-to-Average Ratio	Part 27.50(d)(4)	Pass
99% & -26 dB Occupied Bandwidth	Part 2.1049 Part 27.53(h)	Pass
Spurious Emissions at Antenna Terminal	Part 2.1051 Part 27.53(h)	Pass
Field Strength of Spurious Radiation	Part 2.1053 Part 27.53(h)	Pass
Out of band emission, Band Edge	Part 2.1051 Part 27.53(h)	Pass
Frequency stability	Part 2.1055 Part 27.54	Pass
1.3 Address of the test laboratory		GTA CTA

1.3 Address of the test laboratory

Shenzhen CTA Testing Technology Co., Ltd.

Room 106, Building 1, Yibaolai Industrial Park, Qiaotou Community, Fuhai Street, Bao'an District, Shenzhen, China

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.4:2014 and CISPR 16-1-4:2010 CTATESTING SVSWR requirement for radiated emission above 1GHz.

1.4 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 517856 Designation Number: CN1318

Shenzhen CTA Testing Technology Co., Ltd. has been listed on the US Federal Communications Commission list of test facilities recognized to perform electromagnetic emissions measurements.

Industry Canada Registration Number. Is: 27890 CAB identifier: CN0127

The Laboratory has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing.

A2LA-Lab Cert. No.: 6534.01

Shenzhen CTA Testing Technology Co., Ltd. has been listed by American Association for Laboratory Accreditation to perform electromagnetic emission measurement.

The 3m-Semi anechoic test site fulfils CISPR 16-1-4 according to ANSI C63.10 and CISPR 16-1-

4:2010.

1.5 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. To TR-100028-01" Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 1" and TR-100028-02 "Electromagnetic compatibility and Radio spectrum Matters (ERM);Uncertainties in the measurement of mobile radio equipment characteristics; Part 2 " and is documented in the Shenzhen CTA Testing Technology Co., Ltd. Quality system acc. To DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device. Hereafter the best measurement capability for Shenzhen CTA Testing Technology Co., Ltd. :

Measurement

Measurement

Test	Range	Measuremen t Uncertainty	Notes
Radiated Emission	30~1000MHz	🕝 4.06 dB	(1)
Radiated Emission	1~18GHz	5.14 dB	(1)
Radiated Emission	18-40GHz	5.38 dB	(1)
Conducted Disturbance	0.15~30MHz	2.14 dB	(1)
Output Peak power	30MHz~18GHz	0.55 dB	(1)
Power spectral density	/	0.57 dB	(1)
Spectrum bandwidth	/	1.1%	(1)
Radiated spurious emission (30MHz-1GHz)	30~1000MHz	4.10 dB	(1)
Radiated spurious emission (1GHz-18GHz)	1~18GHz	4.32 dB	(1)
Radiated spurious emission (18GHz-40GHz)	18-40GHz	5.54 dB	(1) گ

 (1) This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



GENERAL INFORMATION 2

2.1 Environmental conditions

Date of receipt of test sample	:	Mar. 25, 2025
TES		
Testing commenced on	:	Mar. 25, 2025
5		TED
Testing concluded on		Apr. 03, 2025
-	RGT	

ATESTING During the measurement the environmental conditions were within the listed ranges:

During the measurement the environmental co	onditions were within the listed ranges:	
Normal Temperature:	25°C	ALL
Relative Humidity:	55 %	
Air Pressure:	101 kPa	

2.2 General Description of EUT

Product Name:	Mobile Phone	
Model/Type reference:	Stone	
Power supply:	DC 3.7V From battery and DC 5.0V From e	external circuit
Adapter information:	Model: Stone Input: AC 100-240V 50/60Hz 0.15A Output: DC 5V 500mA	CTATESTIN
Hardware version:	Z699T_V3.0	C
Software version:	Z699T_JL43A_MARKPHONE_UMS9117L	_V02_202504012014
Testing sample ID :	CTA250325008-1# (Engineer sample) CTA250325008-2# (Normal sample)	
LTE		
Operation Band:	E-UTRA Band 7	GTING
Support Bandwidth:	Band 7: 5MHz,10MHz,15MHz,20MHz,	TEO
TX/RXFrequency Range:	E-UTRA Band 7(2500 MHz -2570MHz)	(ch)
Modulation Type:	QPSK, 16QAM	C
Category:	Cat 4	
Antenna Type:	PIFA antenna	
Antenna Gain:	-0.91dBi	
Note: For more details, re	efer to the user's manual of the EUT.	CTIN

2.3 Description of Test Modes and Test Frequency

The EUT has been tested under typical operating condition. The CMW500 used to control the EUT staying in continuous transmitting and receiving mode for testing. Regards to the frequency band operation: the lowest, middle and highest frequency of channel were selected to perform the test, CTA TESTING then shown on this report.



2.4 Equipments l	Jsed during the	Test		CTA	
Test Equipment	Manufacturer	Model No.	Equipment No.	Calibration Date	Calibration Due Date
LISN	N ^G R&S	ENV216	CTA-308	2024/08/03	2025/08/02
LISN	R&S	ENV216	CTA-314	2024/08/03	2025/08/02
EMI Test Receiver	R&S	ESPI	CTA-307	2024/08/03	2025/08/02
EMI Test Receiver	R&S	ESCI	CTA-306	2024/08/03	2025/08/02
Spectrum Analyzer	Agilent	N9020A	CTA-301	2024/08/03	2025/08/02
Spectrum Analyzer	R&S	FSU	CTA-337	2024/08/03	2025/08/02
Vector Signal generator	Agilent	N5182A	CTA-305	2024/08/03	2025/08/02
Analog Signal Generator	R&S	SML03	CTA-304	2024/08/03	2025/08/02
WIDEBAND RADIO COMMUNICATIO N TESTER	CMW500	R&S	CTA-302	2024/08/03	2025/08/02
Temperature and humidity meter	Chigo	ZG-7020	CTA-326	2024/08/03	2025/08/02
Ultra-Broadband Antenna	Schwarzbeck	VULB9163	CTA-310	2023/10/17	2026/10/16
Horn Antenna	Schwarzbeck	BBHA 9120D	CTA-309	2023/10/13	2026/10/12
Loop Antenna	Zhinan	ZN30900C	CTA-311	2023/10/17	2026/10/16
Broadband Horn Antenna	A-INFOMW	LB-180500H- 2.4F	CTA-336	2023/09/13	2026/09/12
Amplifier	Schwarzbeck	BBV 9745	CTA-312	2024/08/03	2025/08/02
Amplifier	Taiwan chengyi	EMC051845B	CTA-313	2024/08/03	2025/08/02
Directional coupler	NARDA	4226-10	CTA-303	2024/08/03	2025/08/02
High-Pass Filter	XingBo	XBLBQ-GTA18	CTA-402	2024/08/03	2025/08/02
High-Pass Filter	XingBo	XBLBQ-GTA27	CTA-403	2024/08/03	2025/08/02
Automated filter bank	Tonscend	JS0806-F	CTA-404	2024/08/03	2025/08/02
Power Sensor	Agilent	U2021XA	CTA-405	2024/08/03	2025/08/02
Amplifier	Schwarzbeck	BBV9719	CTA-406	2024/08/03	2025/08/02
(en ···	1	TESTIN			
Test Equipment	Manufacturer	Model No.	Version number	Calibration Date	Calibration Due Date
EMI Test Software	Tonscend	TS®JS32-RE	5.0.0.2	N/A	N/A
EMI Test Software	Tonscend	TS®JS32-CE	5.0.0.1	N/A	N/A
RF Test Software	Tonscend	TS®JS1120-3	3.1.65	N/A	N/A

RF Test Software	Tonscend	TS®JS1120	3.1.46	N/A	N/A
		1		G	
2.5 Related Subm	ittal(s) / Grant ((s)			
This submittal(s) (tes		. ,	ly with of the F	CC Part 27 Rul	es.
2.6 Modifications					
No modifications wer	e implemented to	meet testing criteria	a.		
			a.		
resting	CTATESTIN				

TEST CONDITIONS AND RESULTS

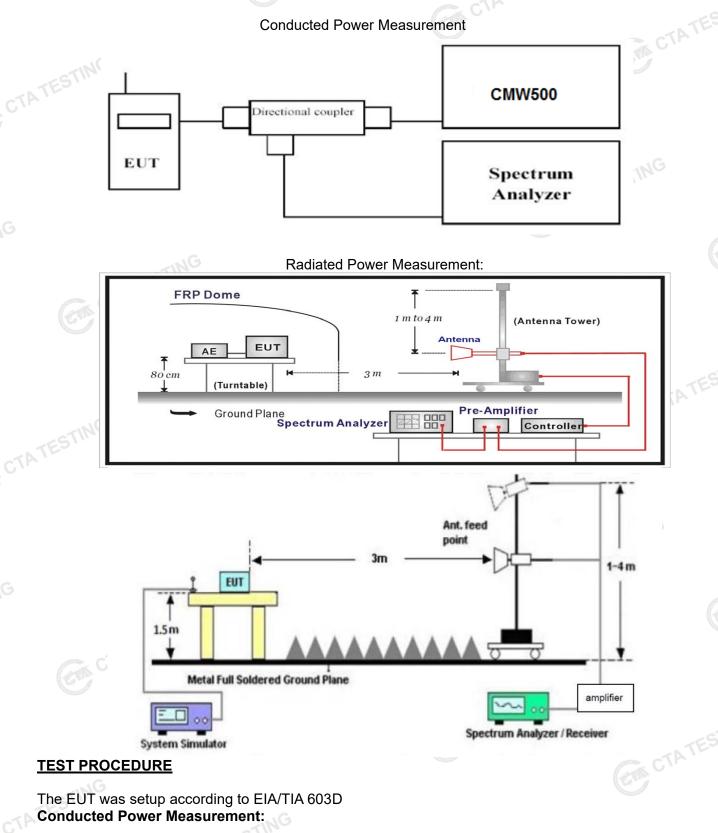
3.1 Output Power

<u>LIMIT</u>

3

According to §27.50 (d) (4): Fixed, mobile, and portable (hand-held) stations operating in the 1710–1755 MHz band are limited to 1 watt EIRP.

TEST CONFIGURATION



- Place the EUT on a bench and set it in transmitting mode. a)
- Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a b) Directional Couple.
- EUT Communicate with CMW500 then selects a channel for testing. c)
- Add a correction factor to the display of spectrum, and then test. d)

Radiated Power Measurement:

- a) The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- The test antenna shall be oriented initially for vertical polarization and shall be chosen to b) correspond to the frequency of the transmitter
- The output of the test antenna shall be connected to the measuring receiver. c)
- The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency d) of the transmitter under test.
- The test antenna shall be raised and lowered through the specified range of height until a e) maximum signal level is detected by the measuring receiver.
- The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum f) signal level is detected by the measuring receiver.
- The test antenna shall be raised and lowered again through the specified range of height until a g) maximum signal level is detected by the measuring receiver.
- The maximum signal level detected by the measuring receiver shall be noted. h)
- i) The transmitter shall be replaced by a substitution antenna.
- The substitution antenna shall be orientated for vertical polarization and the length of the j) substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k) The substitution antenna shall be connected to a calibrated signal generator.
- If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to I) increase the sensitivity of the measuring receiver.
- m) The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- n) The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- The measurement shall be repeated with the test antenna and the substitution antenna **O**) orientated for horizontal polarization.
- p) The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- Test site anechoic chamber refer to ANSI C63.4. q)

TEST RESULTS

Conducted Measurement:

EST RESU	ST RESULTS						
Conducted	Measurement:			ATESTING			
			LTE Band 7	1			
BW	Modulation	RB Size		Cha	annel/Frequency(N	IHz)	
(MHz)	Modulation	IND SIZE	RB Offset	20850	21100	21350	
				2510	2535	2560	
20	QPSK	1	0	23.53	23.07	23.42	
20	QPSK	1	49	23.25	23.06	23.29	
20	QPSK	1	99	23.58	23.58	22.75	
20	QPSK	50	0	21.98	22.25	21.93	
20	QPSK	50	24	22.32	22.29	22.08	
20	QPSK	50	50	22.05	22.32	22.09	
20	QPSK	100	0	22.26	22.22	22.15	
20	16QAM	1	0	22.22	21.85	22.04	
20	16QAM	1	49	22.39	22.30	22.02	
20	16QAM	1	99	22.07	22.37	21.89	
20	16QAM	50	0	21.04	21.06	21.14	
20	16QAM	50	24	21.40	21.12	21.22	
20	16QAM	50	50	21.09	21.18	21.19	
20	16QAM	100	0	21.33	21.47	21.34	





Report No.: CTA25032500806

TES

				7	-	< <u>5</u> \''
BW	Modulation	RB Size	RB Offset	Cha	annel/Frequency(M	Hz)
(MHz)	Wouldtion	IND SIZE	IND Oliset	20825	21100	21375
				2507.5	2535	2562.5
15	QPSK	1	0	23.54	23.31	23.53
15	QPSK	1	37	23.21	23.04	23.40
15	QPSK	1	74	22.89	23.48	22.81
15	QPSK	36	0	21.95	21.82	21.80
15	QPSK	36	20	22.16	22.07	21.99
15	QPSK	36	39	22.19	21.94	22.05
15	QPSK	75	0	21.96	22.12	22.31
15	16QAM	1	0	22.16	22.19	22.10
15	16QAM	1	37	21.85	21.92	22.27
15	16QAM	1	74	22.15	22.06	22.30
15	16QAM	36	0	21.18	21.45	21.28
15	16QAM	36	20	21.01	21.08	21.27
15	16QAM	36	39	21.02	21.12	21.09
15	16QAM	75	0	21.03	21.23	21.10

, CTA

15	16QAM	75	0	21.03	21.23	21.10
15						
				0		AL 1_)
BW	Modulation	RB Size	RB Offset	Cr	nannel/Frequency(N	VIHZ)
(MHz)	wodulation	RD SIZE	RB Oliset	20800	21100	21400
				2505	2535	2565
10	QPSK	1	0	23.27	23.40	22.96
10	QPSK	1	25	23.19	23.63	23.01
10	QPSK	1	49	23.09	23.06	23.66
10	QPSK	25	0	22.24	22.19	22.19
10	QPSK	25	12	21.91	22.04	21.99
10	QPSK	25	25	22.03	22.13	22.14
10	QPSK	50	0	22.22	22.35	21.87
10	16QAM	1	0	22.10	22.26	22.21
10	16QAM	1	25	21.96	22.09	22.21
10	16QAM	1	49	21.94	22.01	21.95
10	16QAM	25	0	21.28	21.23	20.89
10	16QAM	25	12	21.25	21.27	21.11
10	16QAM	25	25	21.06	21.10	21.05
10	16QAM	50	0	21.38	21.44	21.06
BW (MHz)	Modulation	RB Size	RB Offset	<u>20775</u> 2502.5	nannel/Frequency(N 21100 2535	21425 2567.5
5	QPSK	1	0	23.32	23.31	22.91
5	QPSK	1	12	23.46	23.38	23.25
5	QPSK	1	24	22.98	23.59	23.25
5	QPSK	12	0	22.15	21.97	22.18
5	QPSK	12	7	22.19	22.15	22.09
5	QPSK	12	13	22.01	22.41	21.89
5	QPSK	25	0	22.09	21.90	22.25
5	16QAM	1	0	21.99	22.26	22.07
5	16QAM	1	12	22.08	22.09	22.11
5	16QAM	1	24	22.25	21.81	21.94
5	16QAM	12	0	21.13	21.27	21.36
5	16QAM	12	7	21.28	21.07	21.30
5	16QAM	12	13	21.14	21.50	20.96
5	16QAM	25	0	21.48	21.12	21.21
			0 A TESTING		TATESTING	



Radiated Measurement: Remark:

- 1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 7; recorded worst case for each Channel Bandwidth of LTE FDD Band 7.
- 2. $EIRP=P_{Mea}(dBm)-P_{cl}(dB)+P_{Ag}(dB)+G_{a}(dBi)$

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Ga Antenna	PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
2502.5	-19.29	3.06	Gain(dB) 9.68	34.8	22.13	33.01	-10.88	V
2535	-18.97	3.17	9.68	34.8	22.34	33.01	-10.67	V
2567.5	-18.86	3.22	9.75	34.8	22.47	33.01	-10.54	V CTP

LTE FDD Band 7_Channel Bandwidth 5MHz_QPSK

LTE FDD Band 7 Channel Bandwidth 10MHz QPSK

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Ga Antenna Gain(dB)	PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization		
2505	-19.25	3.06	9.68	34.8	22.17	33.01	-10.84	V		
2535	-19.43	3.17	9.68	34.8	21.88	33.01	-11.13	VG		
2565	-19.13	3.22	9.75	34.8	22.20	33.01	-10.81	SV		
LTE FDD Band 7_Channel Bandwidth 15MHz_QPSK										
			G			1	4.1			

LTE FDD Band 7_Channel Bandwidth 15MHz QPSK

Frequency (MHz)	PMea (dBm)	Pcl G (dB)	Ga Antenna Gain(dB)	PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization		
2507.5	-19.30	3.06	9.68	34.8	22.12	33.01	-10.89	V		
2535	-18.70	3.17	9.68	34.8	22.61	33.01	-10.40	V		
2562.5	-18.67	3.22	9.75	34.8	22.66	33.01	-10.35	V		
LTE FDD Band 7_Channel Bandwidth 20MHz_QPSK										
			Ga			212				

LTE FDD Band 7 Channel Bandwidth 20MHz QPSK

	Frequency (MHz)	PMea (dBm)	Pcl (dB)	Ga Antenna Gain(dB)	PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
	2510	-19.11	3.06	9.68	34.8	22.31	33.01	-10.70	V
	2535	-19.39	3.17	9.68	34.8	21.92	33.01	-11.09	V
TA	2560	-19.07	3.22	9.75	34.8	22.26	33.01	-10.75	V
GV			-9	TIN			•	•	

LTE FDD Band 7 Channel Bandwidth 5MHz 16QAM

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Ga Antenna Gain(dB)	PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
2502.5	-20.05	3.06	9.68	34.8	21.37	33.01	-11.64	V
2535	-20.34	3.17	9.68	34.8	20.97	33.01	-12.04	V
2567.5	-20.24	3.22	9.75	34.8	21.09	33.01	-11.92	V

LTE FDD Band 7_Channel Bandwidth 10MHz 16QAM

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Ga Antenna Gain(dB)	PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	
2505	-20.31	3.06	9.68	34.8	21.11	33.01	-11.90	V	
2535	-20.14	3.17	9.68	34.8	21.17	33.01	-11.84	V	
2565	-19.88	3.22	9.75	34.8	21.45	33.01	-11.56	V	12-
STING					G	7		COM CTA	TESI

Report No.: CTA25032500806

Page 13 of 23

LTE FDD Band 7_Channel Bandwidth 15MHz_16QAM

Report No.:	CTA25032	00800					Pa				
LTE FDD Bai	_TE FDD Band 7_Channel Bandwidth 15MHz_16QAM										
Frequency (MHz)	PMea (dBm)	Pcl (dB)	Ga Antenna Gain(dB)	PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization			
2507.5	-20.03	[©] 3.06	9.68	34.8	21.39	33.01	-11.62	V			
2535	-19.70	3.17	9.68	34.8	21.61	33.01	-11.40	V			
2562.5	-19.60	3.22	9.75	34.8	21.73	33.01	-11.28	V			

LTE FDD Band 7 Channel Bandwidth 20MHz 16QAM

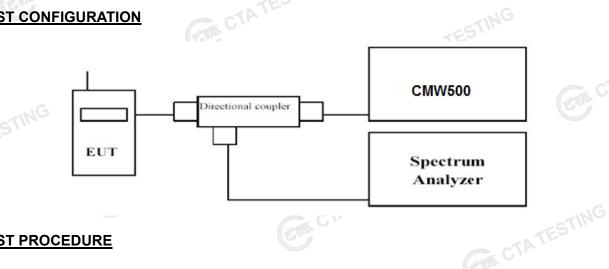
	LTE FDD Bar Frequency (MHz)	nd 7 <u>Char</u> PMea (dBm)	Pcl (dB)	<i>width</i> 20MH Ga Antenna Gain(dB)	z_16QAM PAg (dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization	TES
	2510	-19.87	3.06	9.68	34.8	21.55	33.01	-11.46	V CTP	
	2535	-20.43	3.17	9.68	34.8	20.88	33.01	-12.13	V	
	2560	-20.00	3.22	9.75	34.8	21.33	33.01	-11.68	V	
CTA	TEC	GM	CTATES	STING	CA CT	ATESTI	ŊĠ		STING	



LIMIT

The Peak-to-Average Ratio (PAR) of the transmission may not exceed 13 dB.

TEST CONFIGURATION



TEST PROCEDURE

- 1. Refer to instrument's analyzer instruction manual for details on how to use the power statistics/CCDF function;
 - Set resolution/measurement bandwidth ≥ signal's occupied bandwidth;
 - 3. Set the number of counts to a value that stabilizes the measured CCDF curve;
 - 4. Set the measurement interval as follows:
 - 1). for continuous transmissions, set to 1 ms,

2). for burst transmissions, employ an external trigger that is synchronized with the EUT burst CTATEST timing sequence, or use the internal burst trigger with a trigger level that allows the burst to stabilize and set the measurement interval to a time that is less than or equal to the burst duration.

---Passed-----

5. Record the maximum PAPR level associated with a probability of 0.1%.

TEST RESULTS

Please refer to the appendix test data.



Occupied Bandwidth and Emission Bandwidth 3.3 LIMIT

N/A **TEST CONFIGURATION** STING CMW500 Directional coupler EUT Spectrum Analyzer CTATESTING

TEST PROCEDURE

The transmitter output was connected to a calibrated coaxial cable and coupler, the other end of which was connected to a spectrum analyzer. The occupied bandwidth was measured with the spectrum analyzer at low, middle and high channel in each band. The -26dBc Emission bandwidth was also measured and recorded.

Set RBW was set to about 1% of emission BW, VBW≥3 times RBW.

-26dBc display line was placed on the screen (or 99% bandwidth), the occupied bandwidth is the delta frequency between the two points where the display line intersects the signal trace.

-----Passed------

TEST RESULTS

Please refer to the appendix test data. ..d.

3.4 Band Edge compliance

LIMIT

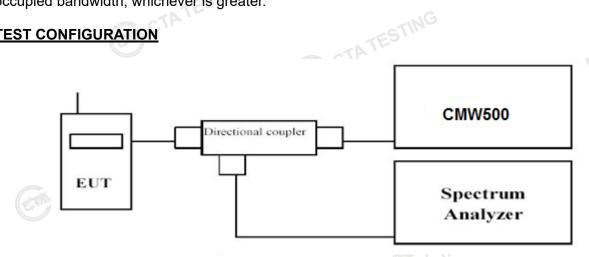
Equipment shall comply with the following unwanted emission limits:

- for base station and fixed subscriber equipment, the power of any unwanted emissions a) measured as above shall be attenuated (in dB) below the transmitter power, P (dBW), by at least 43 + 10 log10 p
- b) for mobile subscriber equipment, the power of any unwanted emissions measured as above shall be attenuated (in dB) below the transmitter power, P (dBW), by at least:
 - 40 + 10 log10 p from the channel edges to 5 MHz away
 - 43 + 10 log10 p between 5 MHz and X MHz from the channel edges, and
 - 55 + 10 log10 p at X MHz and beyond from the channel edges

In addition, the attenuation shall not be less than 43 + 10 log10 p on all frequencies between 2490.5 MHz and 2496 MHz, and 55 + 10 log10 p at or below 2490.5 MHz.

In (a) and (b), p is the transmitter power measured in watts and X is 6 MHz or the equipment occupied bandwidth, whichever is greater.

TEST CONFIGURATION



TEST PROCEDURE

- 1. The transmitter output port was connected to base station.
- The RF output of EUT was connected to the power meter by RF cable and attenuator, the path
- loss was compensated to the results for each measurement. 3. Set EUT at maximum power through base station.
- 4. Select lowest and highest channels for each band and different modulation.
- 5. Measure Band edge using RMS (Average) detector by spectrum

TEST RESULTS

---Passed-----

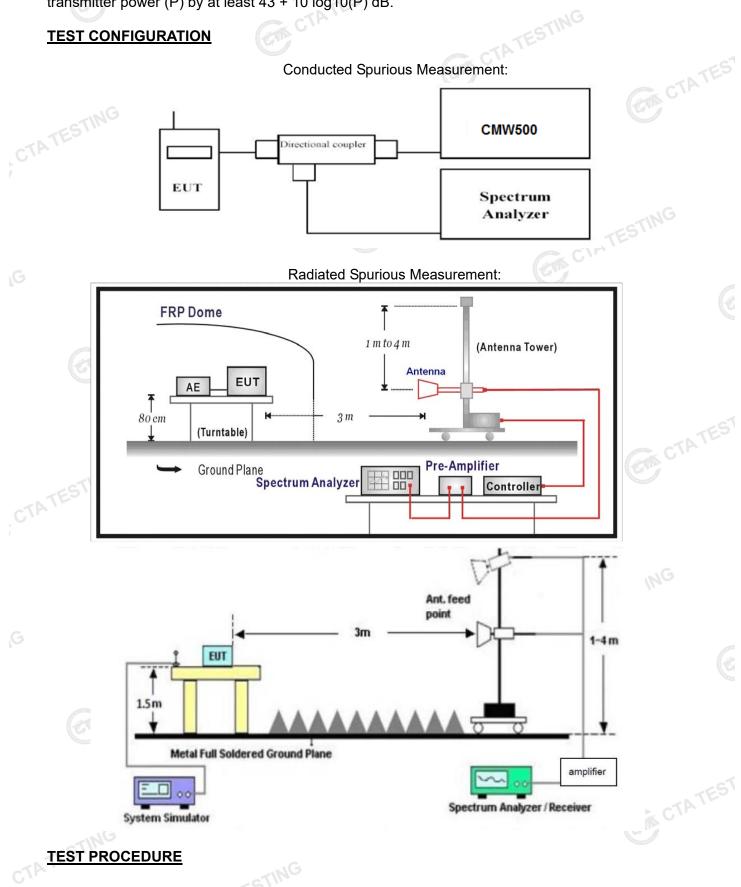
Please refer to the appendix test data. GTA TESTIN

3.5 Spurious Emission

LIMIT

According to §27.53 (h): For operations in the 1710–1755 MHz and 2110–2155 MHz bands, the power of any emission outside a licensee's frequency block shall be attenuated below the transmitter power (P) by at least 43 + 10 log10(P) dB.

TEST CONFIGURATION



The EUT was setup according to EIA/TIA 603D

Conducted Spurious Measurement:

- a. Place the EUT on a bench and set it in transmitting mode.
- b. Connect a low loss RF cable from the antenna port to a spectrum analyzer and CMW500 by a Directional Couple.
- c. EUT Communicate with CMW500 then selects a channel for testing.
- d. Add a correction factor to the display of spectrum, and then test.
- e. The resolution bandwidth of the spectrum analyzer was set sufficient scans were taken to show the out of band Emission if any up to10th harmonic.

Radiated Spurious Measurement:



- a. The EUT shall be placed at the specified height on a support, and in the position closest to normal use as declared by provider.
- b. The test antenna shall be oriented initially for vertical polarization and shall be chosen to correspond to the frequency of the transmitter
- c. The output of the test antenna shall be connected to the measuring receiver.
- d. The transmitter shall be switched on and the measuring receiver shall be tuned to the frequency of the transmitter under test.
- e. The test antenna shall be raised and lowered through the specified range of height until a maximum signal level is detected by the measuring receiver.
- f. The transmitter shall then be rotated through 360° in the horizontal plane, until the maximum signal level is detected by the measuring receiver.
- The test antenna shall be raised and lowered again through the specified range of height until a g. maximum signal level is detected by the measuring receiver.
- h. The maximum signal level detected by the measuring receiver shall be noted.
- The transmitter shall be replaced by a substitution antenna. ì.
- The substitution antenna shall be orientated for vertical polarization and the length of the j. substitution antenna shall be adjusted to correspond to the frequency of the transmitter.
- k. The substitution antenna shall be connected to a calibrated signal generator.
- If necessary, the input attenuator setting of the measuring receiver shall be adjusted in order to Ι. increase the sensitivity of the measuring receiver.
- m. The test antenna shall be raised and lowered through the specified range of height to ensure that the maximum signal is received.
- n. The input signal to the substitution antenna shall be adjusted to the level that produces a level detected by the measuring receiver, that is equal to the level noted while the transmitter radiated power was measured, corrected for the change of input attenuator setting of the measuring receiver.
- o. The measurement shall be repeated with the test antenna and the substitution antenna orientated for horizontal polarization.
- p. The measure of the effective radiated power is the larger of the two levels recorded at the input to the substitution antenna, corrected for gain of the substitution antenna if necessary.
- CTATEST q. The resolution bandwidth of the spectrum analyzer was set at 100 kHz for Part 22 and 1MHz for Part 24. The frequency range was checked up to 10th harmonic.

Passed-----ESTING

r. Test site anechoic chamber refer to ANSI C63.

TEST RESULTS

Conducted Measurement:

Please refer to the appendix test data.

Radiated Measurement:

Remark:

1. We were tested all RB Configuration refer 3GPP TS136 521 for each Channel Bandwidth of LTE FDD Band 7

TESTIN		
LTE FDD Band 7_Channel Bandwidth 20MH	QPSK_	Low Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Distance (m)	Ga Antenna Gain(dB)	Peak EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
5020	-40.83	5.11	3.00	13.38	-32.56	-25.00	-7.56	Н
7530	-54.90	6.02	3.00	13.98	-46.94	-25.00	-21.94	Н
5020	-44.70	5.11	3.00	13.38	-36.43	-25.00	-11.43	V CTP
7530	-49.99	6.02	3.00	13.98	-42.03	-25.00	-17.03	V

LTE FDD Band 7 Channel Bandwidth 20MHz QPSK Middle Channel

Frequency (MHz)	PMea (dBm)	Pcl (dB)	Distance (m)	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization
5070	-41.51	5.21	3.00	13.54	-33.18	-25.00	-8.18	HG
7605	-49.33	6.14	3.00	14.13	-41.34	-25.00	-16.34	STH
5070	-45.48	5.21	3.00	13.54	-37.15	-25.00	-12.15	V
7605	-53.51	6.14	3.00	14.13	-45.52	-25.00	-20.52	V
					o, ,	6		

LTE FDD 7 Channel Bandwidth 20MHz QPSK High Channel

Frequency (MHz)	PMea (dBm)	G Pcl (dB)	Distance (m)	Ga Antenna Gain(dB)	EIRP (dBm)	Limit (dBm)	Margin (dB)	Polarization		
5120	-41.81	5.3	3.00	13.69	-33.42	-25.00	-8.42	Н		
7680	-46.64	6.25	3.00	14.25	-38.64	-25.00	-13.64	Н		
5120	-40.96	5.3	3.00	13.69	-32.57	-25.00	-7.57	V		
7680	-54.07	6.25	3.00	14.25	-46.07	-25.00	-21.07	V		
Notes: 1.All channel bandwidth were tested,the report recorded the worst data. 2. EIRP=PMea(dBm)-Pcl(dB)+PAg(dB)+Ga(dBi)										

3. ERP = EIRP – 2.15dBi as EIRP by subtracting the gain of the dipole.

4. Margin = EIRP – Limit

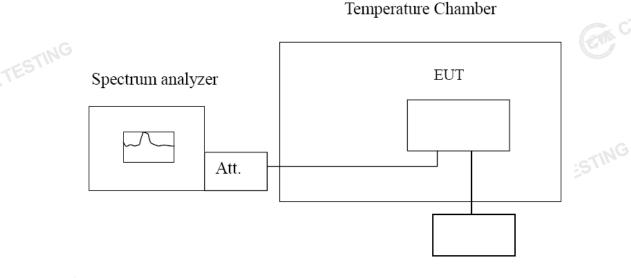
CTA TESTING 5. We measured all modes and only recorded the worst case.

Frequency Stability under Temperature & Voltage Variations 3.6

LIMIT

According to §27.54, §2.1055 requirement, the frequency stability shall be sufficient to ensure that the fundamental emissions stay within the authorized bands of operation and should not exceed 2.5ppm. CTATESTING

TEST CONFIGURATION



Variable Power Supply

TEST PROCEDURE

The EUT was setup according to EIA/TIA 603D

Frequency Stability under Temperature Variations:

TATES In order to measure the carrier frequency under the condition of AFC lock, it is necessary to make measurements with the EUT in a "call mode". This is accomplished with the use of R&S CMW500 DIGITAL RADIO COMMUNICATION TESTER.

- Measure the carrier frequency at room temperature. 1.
- Subject the EUT to overnight soak at -30°C. 2.
- With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call 3. on middle channel for LTE band 12, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
- 4. Repeat the above measurements at 10°C increments from -30°C to +50°C. Allow at least 1.5 hours at each temperature, unpowered, before making measurements.
- Re-measure carrier frequency at room temperature with nominal voltage. Vary supply voltage 5. from minimum voltage to maximum voltage, in 0.1Volt increments re-measuring carrier frequency at each voltage. Pause at nominal voltage for 1.5 hours unpowered, to allow any selfheating to stabilize, before continuing.
- Subject the EUT to overnight soak at $+50^{\circ}$ C. 6.
- With the EUT, powered via nominal voltage, connected to the CMW500 and in a simulated call 7. on the centre channel, measure the carrier frequency. These measurements should be made within 2 minutes of Powering up the EUT, to prevent significant self-warming.
- Repeat the above measurements at 10 °C increments from +50 °C to -30 °C. Allow at least 1.5 8. hours at each temperature, unpowered, before making measurements
- 9. At all temperature levels hold the temperature to $+/-0.5^{\circ}$ during the measurement procedure. Frequency Stability under Voltage Variations:

Set chamber temperature to 20°C. Use a variable AC power supply / DC power source to power the EUT and set the voltage to rated voltage. Set the spectrum analyzer RBW low enough to obtain the desired frequency resolution and recorded the frequency.

Reduce the input voltage to specify extreme voltage variation (±15%) and endpoint, record the maximum frequency change.

---Passed------

TEST RESULTS

Please refer to the appendix test data.

-JO CTATES Test Setup Photos of the EUT 4 CTATESTING CTATESTING Reference to the test report No. CTA25032500801. GA CTATESTING